

### **PHOTOCOUPLER**

## PS2505-1,-2,-4, PS2505L-1,-2,-4

# HIGH ISOLATION VOLTAGE AC INPUT RESPONSE TYPE MULTI PHOTOCOUPLER SERIES

-NEPOC<sup>™</sup> Series-

#### **DESCRIPTION**

The PS2505-1, -2, -4 and PS2505L-1, -2, -4 are optically coupled isolators containing GaAs light emitting diodes and an NPN silicon phototransistor.

The PS2505-1, -2, -4 are in a plastic DIP (Dual In-line Package) and the PS2505L-1, -2, -4 are lead bending type (Gull-wing) for surface mount.

#### **FEATURES**

- · AC input response
- High isolation voltage (BV = 5 000 Vr.m.s.)
- High collector to emitter voltage (VcEo = 80 V)
- High-speed switching ( $t_r = 3 \mu s$  TYP.,  $t_f = 5 \mu s$  TYP.)
- Ordering number of taping product: PS2505L-1-E3, E4, F3, F4, PS2505L-2-E3, E4
- UL approved: File No. E72422 (S)

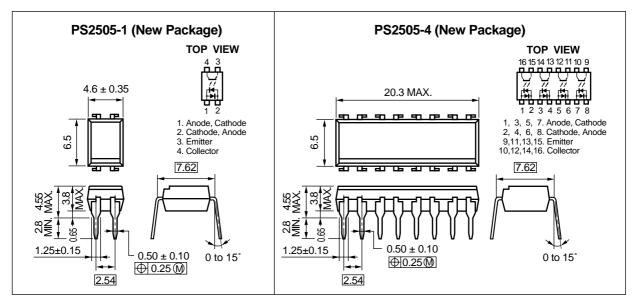
### **APPLICATIONS**

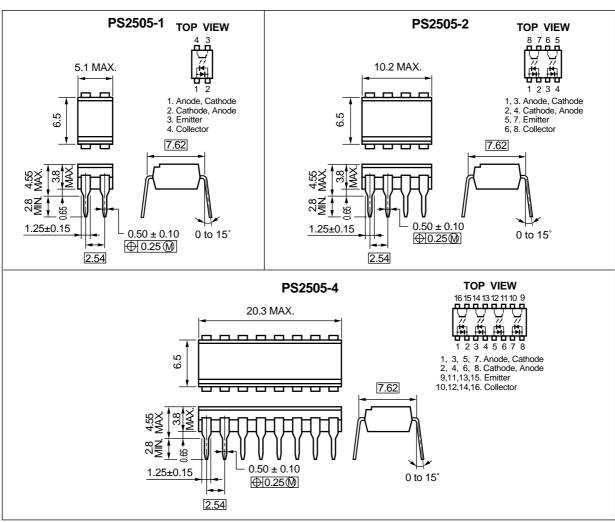
- Power supply
- Telephone/FAX.
- FA/OA equipment
- · Programmable logic controller

The information in this document is subject to change without notice.

#### **★ PACKAGE DIMENSIONS (in millimeters)**

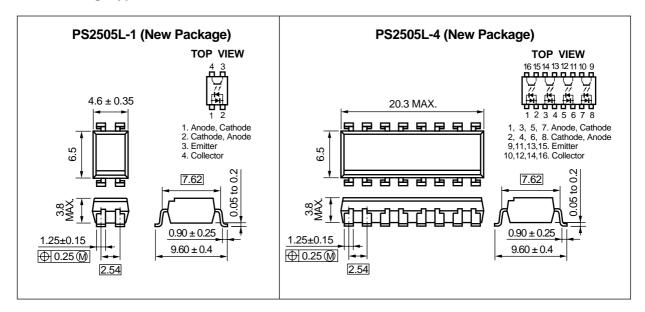
### **DIP Type**

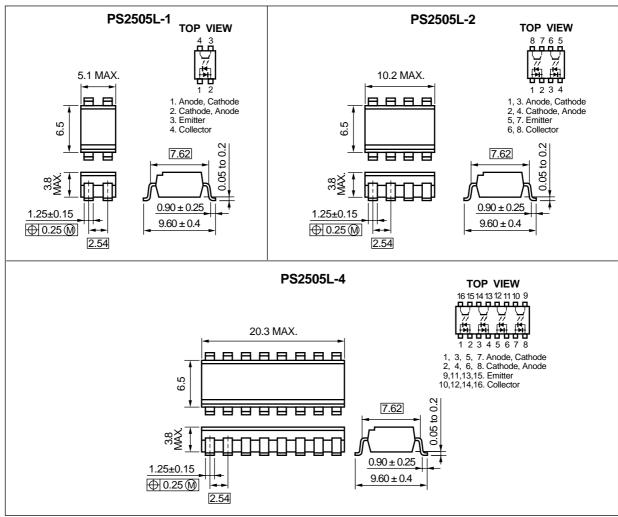




Caution New package 1-ch, 4-ch only

### Lead Bending Type





Caution New package 1-ch, 4-ch only

### ABSOLUTE MAXIMUM RATINGS (TA = 25 °C, unless otherwise specified)

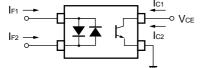
Parameter			Rati		
		Symbol	PS2505-1, PS2505L-1	PS2505-2,-4 PS2505L-2,-4	Unit
Diode	Forward Current (DC)	<b>I</b> F	±8	mA	
	Power Dissipation Derating	∆P₀/°C	1.5	1.2	mW/°C
	Power Dissipation	Po	150	120	mW/ch
	Peak Forward Current*1	IFP	±1		Α
Transistor	Collector to Emitter Voltage	VCEO	80 7 50		٧
	Emitter to Collector Voltage	VECO			V
	Collector Current	lc			mA/ch
	Power Dissipation Derating	∆Pc/°C	1.5	1.2	mW/°C
	Power Dissipation	Pc	150	120	mW/ch
Isolation Voltage*2		BV	5 000		Vr.m.s.
Operating Ambient Temperature		TA	-55 to +100		°C
Storage Temperature		T <sub>stg</sub>	-55 to +150		°C

<sup>\*1</sup> PW = 100  $\mu$ s, Duty Cycle = 1 %

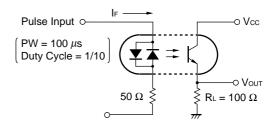
### ELECTRICAL CHARACTERISTICS (TA = 25 °C)

Parameter		Symbol	Conditions	MIN.	TYP.	MAX.	Unit
Diode	Forward Voltage	VF	$I_F = \pm 10 \text{ mA}$		1.17	1.4	V
	Terminal Capacitance	Ct	V = 0 V, f = 1.0 MHz		100		pF
Transistor	Collector to Emitter Dark Current	ICEO	VcE = 80 V, IF = 0 mA			100	nA
Coupled	Current Transfer Ratio (Ic/IF)	CTR	$I_F = \pm 5 \text{ mA}, \text{ Vce} = 5 \text{ V}$	80	300	600	%
	CTR Ratio*1	CTR1/ CTR2	IF = 5 mA, VcE = 5 V	0.3	1.0	3.0	
	Collector Saturation Voltage	VCE (sat)	I <sub>F</sub> = ±10 mA, I <sub>C</sub> = 2 mA			0.3	V
	Isolation Resistance	R <sub>I-O</sub>	Vi-o = 1.0 kVpc	10 <sup>11</sup>			Ω
	Isolation Capacitance	C <sub>I-O</sub>	V = 0 V, f = 1.0 MHz		0.5		pF
	Rise Time *2	tr	$Vcc = 10 \text{ V}, \text{ Ic} = 2 \text{ mA}, \text{ RL} = 100 \Omega$		3		μs
	Fall Time *2	tf			5		

<sup>\*1</sup> CTR1 =  $Ic_1/I_{F1}$ , CTR2 =  $Ic_2/I_{F2}$ 



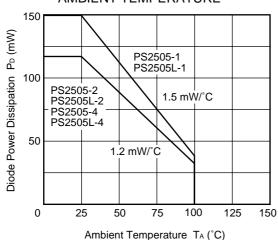
\*2 Test circuit for switching time



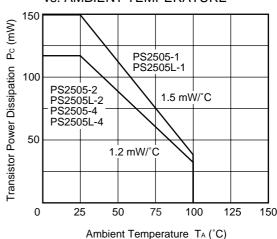
<sup>\*2</sup> AC voltage for 1 minute at T<sub>A</sub> = 25 °C, RH = 60 % between input and output

#### TYPICAL CHARACTERISTICS (TA = 25 °C, unless otherwise specified)

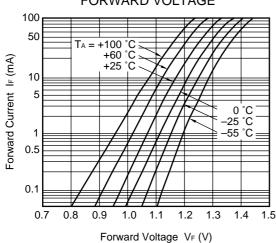




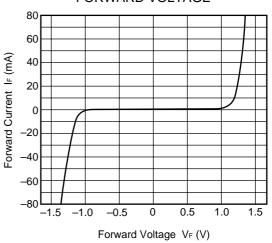
### TRANSISTOR POWER DISSIPATION vs. AMBIENT TEMPERATURE



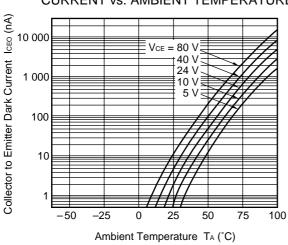
### FORWARD CURRENT vs. FORWARD VOLTAGE



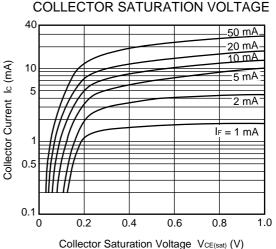
FORWARD CURRENT vs. FORWARD VOLTAGE



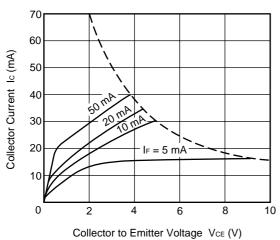
### COLLECTOR TO EMITTER DARK CURRENT vs. AMBIENT TEMPERATURE



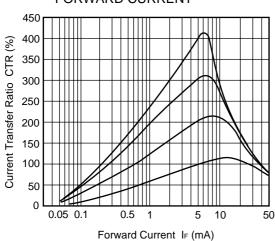
COLLECTOR CURRENT vs.



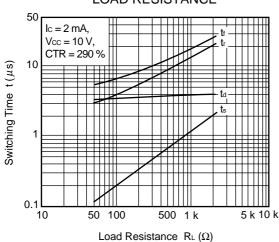
### COLLECTOR CURRENT vs. COLLECTOR TO EMITTER VOLTAGE



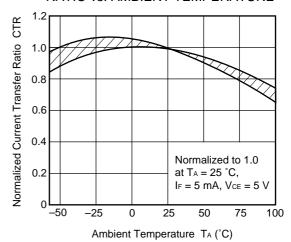
### CURRENT TRANSFER RATIO vs. FORWARD CURRENT



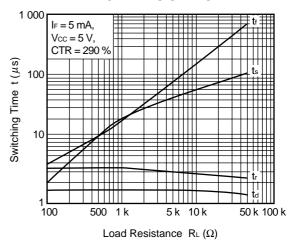
### SWITCHING TIME vs. LOAD RESISTANCE



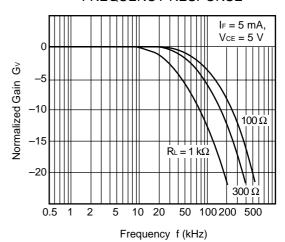
### NORMALIZED CURRENT TRANSFER RATIO vs. AMBIENT TEMPERATURE

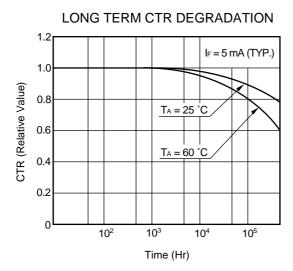


### SWITCHING TIME vs. LOAD RESISTANCE



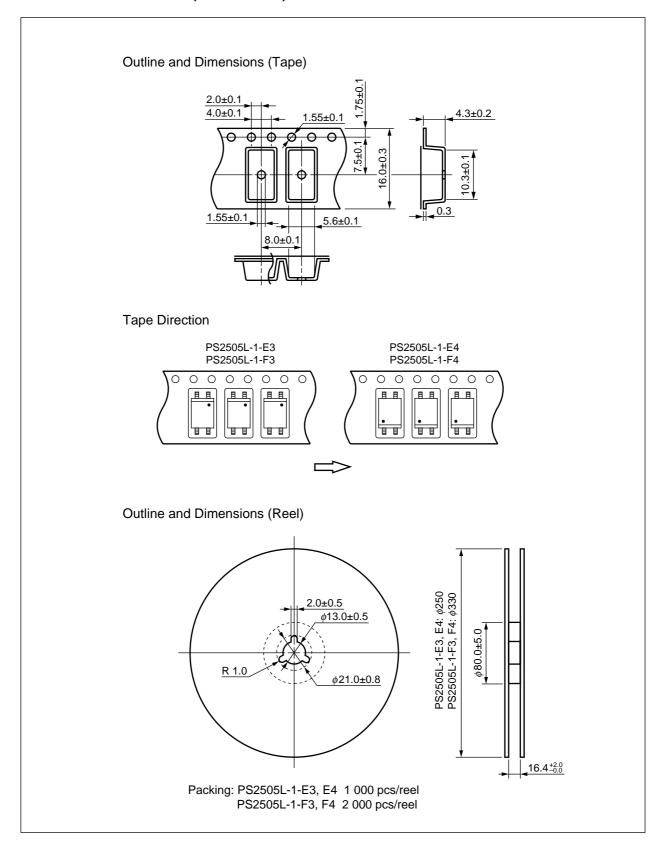
### FREQUENCY RESPONSE

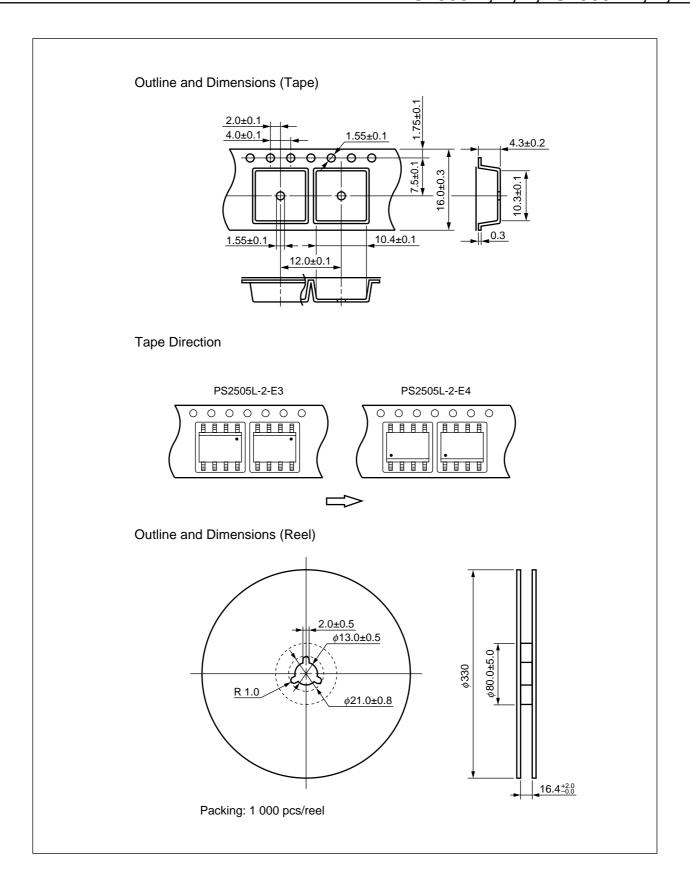




Remark The graphs indicate nominal characteristics.

### **TAPING SPECIFICATIONS (in millimeters)**





### RECOMMENDED SOLDERING CONDITIONS

### (1) Infrared reflow soldering

• Peak reflow temperature 235 °C (package surface temperature)

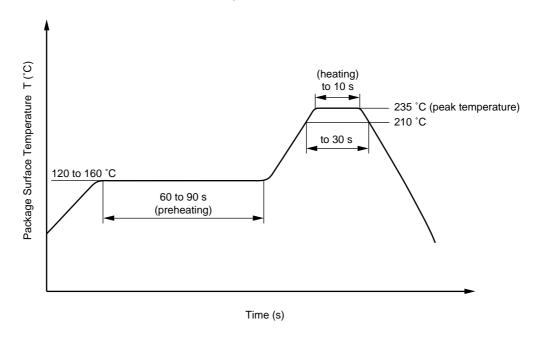
• Time of temperature higher than 210 °C 30 seconds or less

• Number of reflows Three

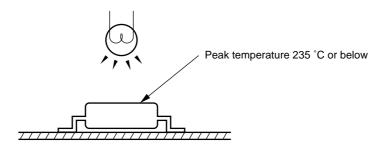
• Flux Rosin flux containing small amount of chlorine (The flux with a maximum chlorine content of 0.2 Wt % is recommended.)

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### Recommended Temperature Profile of Infrared Reflow



Caution Avoid removing the residual flux with chlorine-based cleaning solvent after a reflow process.



### (2) Dip soldering

• Temperature 260 °C or below (molten solder temperature)

• Time 10 seconds or less

• Number of times One

• Flux Rosin flux containing small amount of chlorine (The flux with a maximum chlorine content of

0.2 Wt % is recommended.)

[MEMO]

#### **CAUTION**

Within this device there exists GaAs (Gallium Arsenide) material which is a harmful substance if ingested. Please do not under any circumstances break the hermetic seal.

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Anti-radioactive design is not implemented in this product.

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